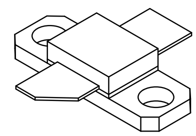
The RF Line
NPN Silicon RF Power Transistor

MRF15030

30 W, 1.5 GHz
RF POWER TRANSISTOR
NPN SILICON



CASE 395C–01, STYLE 1

Designed for 26 volts microwave large–signal, common emitter, class A and class AB linear amplifier applications in industrial and commercial FM/AM equipment operating in the range 1400–1600 MHz.

- Specified 26 Volts, 1490 MHz, Class AB Characteristics:
  Output Power — 30 Watts
  Gain — 9 dB Min @ 30 Watts (PEP)
  Efficiency — 30% Min @ 30 Watts (PEP)
  Intermodulation Distortion — –30 dBc Max @ 30 Watts (PEP)
- Third Order Intercept Point — 53.5 dBm Typ @ 1490 MHz, V_{CE} = 24 Vdc, I_C = 2.5 Adc
- Characterized with Series Equivalent Large–Signal Parameters from 1400–1600 MHz
- Characterized with Small Signal S–Parameters from 1000–2000 MHz
- Silicon Nitride Passivated
- 100% Tested for Load Mismatch Stress at all Phase Angles with 3:1 Load VSWR @ 28 Vdc, at Rated Output Power
- Gold Metallized, Emitter Ballasted for Long Life and Resistance to Metal Migration
- Circuit board photomaster available upon request by contacting RF Tactical Marketing in Phoenix, AZ.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	V_{CEO}	25	Vdc
Collector–Emitter Voltage	V_{CES}	60	Vdc
Emitter–Base Voltage	V_{EBO}	4	Vdc
Collector–Current — Continuous	I_C	10	Adc
Total Device Dissipation @ T_C = 25°C Derate above 25°C	P_D	125 0.71	Watts W/°C
Storage Temperature Range	T_{stg}	–65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.40	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector–Emitter Breakdown Voltage (I_C = 50 mAdc, I_B = 0)	$V_{(BR)CEO}$	25	29	—	Vdc
Collector–Emitter Breakdown Voltage (I_C = 50 mAdc, V_{BE} = 0)	$V_{(BR)CES}$	60	64	—	Vdc
Collector–Emitter Breakdown Voltage (I_C = 50 mAdc, R_{BE} = 100 Ω)	$V_{(BR)CER}$	30	52	—	Vdc

(continued)

MOTOROLA

ELECTRICAL CHARACTERISTICS — continued (T_C = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS — continued					
Emitter–Base Breakdown Voltage (I_E = 5 mAdc, I_C = 0)	$V_{(BR)EBO}$	4	5	—	Vdc
Collector Cutoff Current (V_{CE} = 30 Vdc, V_{BE} = 0)	I_{CES}	—	—	10	mAdc
ON CHARACTERISTICS					
DC Current Gain (I_{CE} = 1 Adc, V_{CE} = 5 Vdc)	h_{FE}	20	35	80	—
DYNAMIC CHARACTERISTICS					
Output Capacitance (V_{CB} = 26 Vdc, I_E = 0, f = 1 MHz)	C_{ob}	—	38	—	pF
FUNCTIONAL TESTS (Figure 12)					
Common–Emitter Amplifier Power Gain (V_{CC} = 26 Vdc, P_{out} = 30 W (PEP), I_{CQ} = 125 mA, f_1 = 1490 MHz, f_2 = 1490.1 MHz)	G_{pe}	9.0	9.6	—	dB
Collector Efficiency (V_{CC} = 26 Vdc, P_{out} = 30 W (PEP), I_{CQ} = 125 mA, f_1 = 1490 MHz, f_2 = 1490.1 MHz)	η	30	34	—	%
Intermodulation Distortion (V_{CC} = 26 Vdc, P_{out} = 30 W (PEP), I_{CQ} = 125 mA, f_1 = 1490 MHz, f_2 = 1490.1 MHz)	IMD	—	– 34	– 30	dBc
Input Return Loss (V_{CC} = 26 Vdc, P_{out} = 30 W (PEP), I_{CQ} = 125 mA, f_1 = 1490 MHz, f_2 = 1490.1 MHz)	IRL	12	15	—	dB
Load Mismatch (V_{CC} = 28 Vdc, P_{out} = 30 W (PEP), I_{CQ} = 125 mA, f_1 = 1490 MHz, f_2 = 1490.1 MHz, Load VSWR = 3:1, All Phase Angles at Frequency of Test)	ψ	No Degradation in Output Power			

TYPICAL CHARACTERISTICS

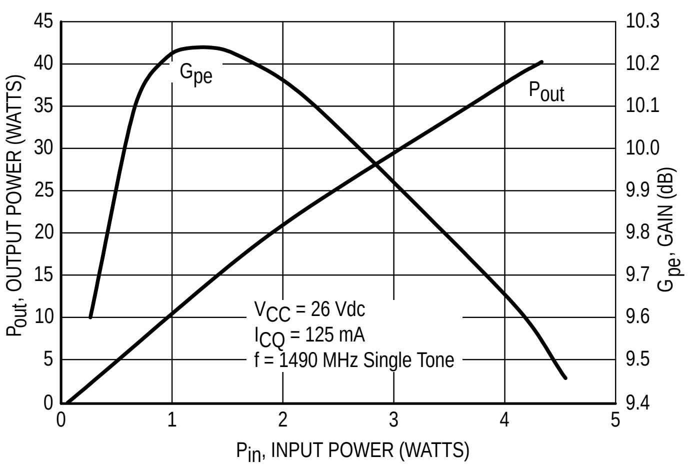


Figure 1. Output Power & Power Gain versus Input Power

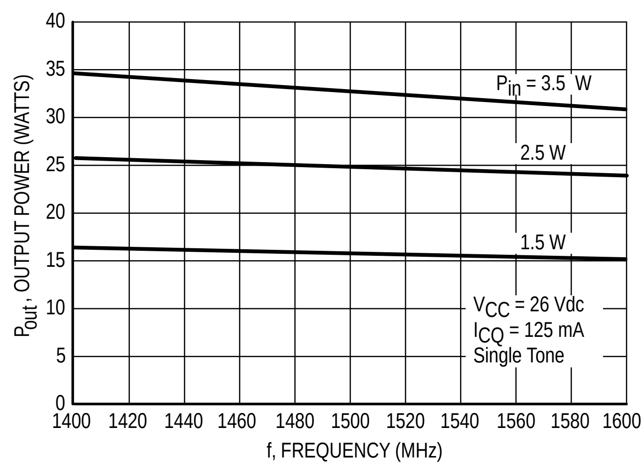


Figure 2. Output Power versus Frequency

TYPICAL CHARACTERISTICS

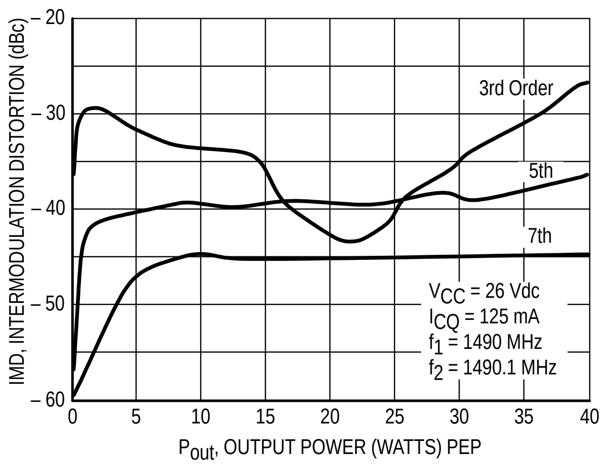


Figure 3. Intermodulation Distortion versus Output Power

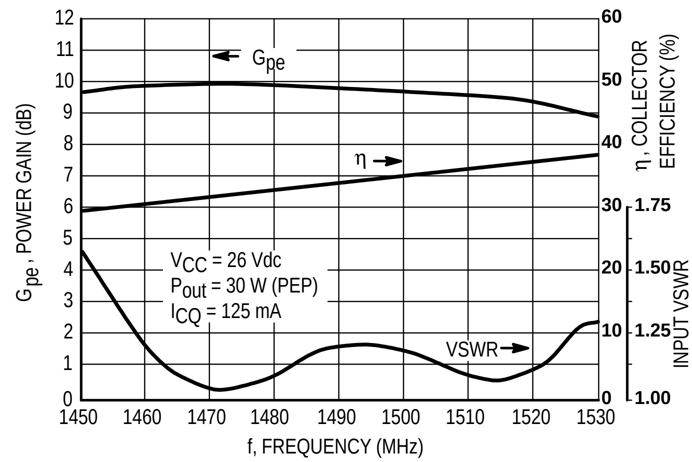


Figure 4. Performance in Broadband Circuit

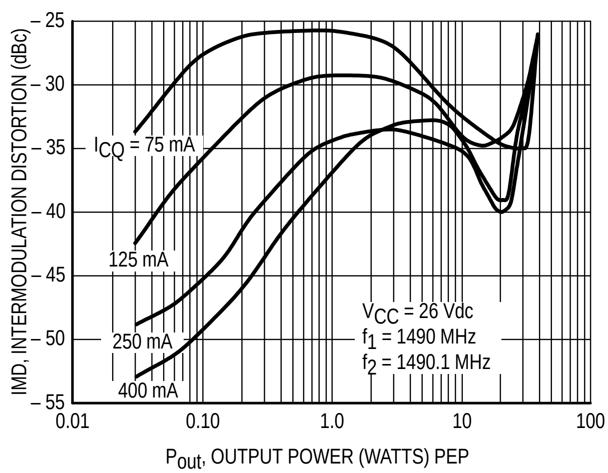


Figure 5. Intermodulation Distortion versus Output Power

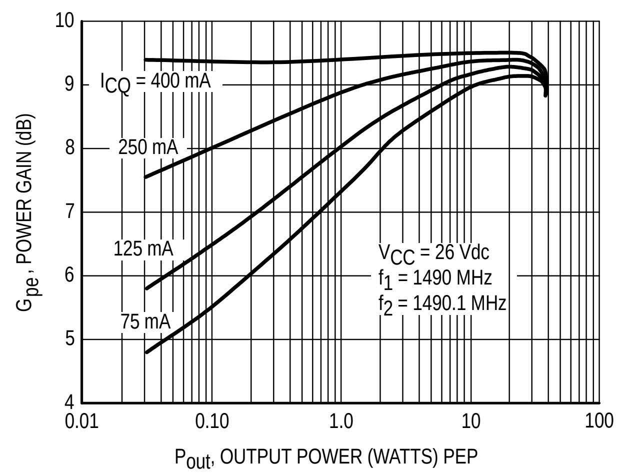


Figure 6. Power Gain versus Output Power

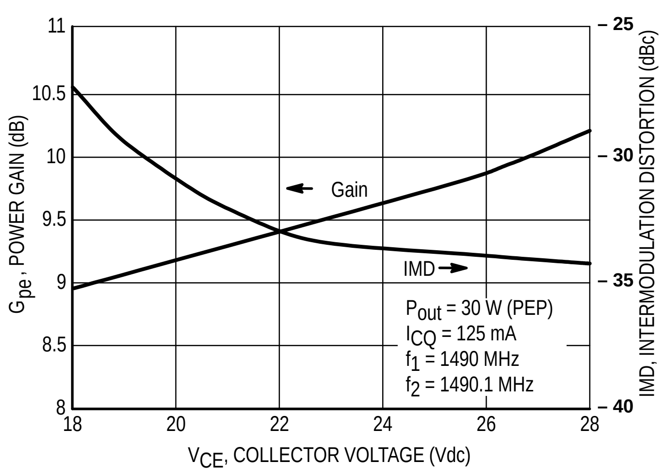


Figure 7. Power Gain and Intermodulation Distortion versus Collector Voltage

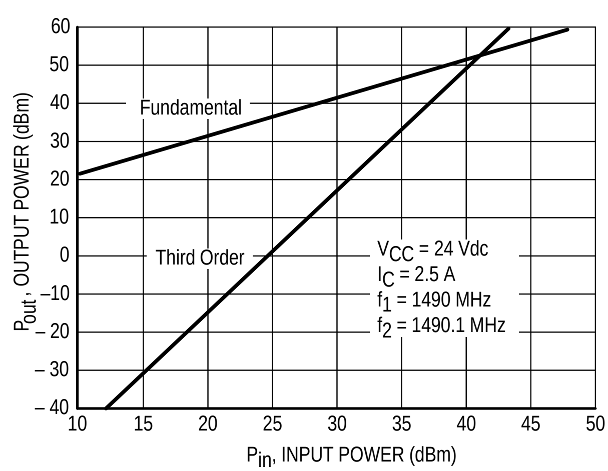


Figure 8. Class A Third Order Intercept Point

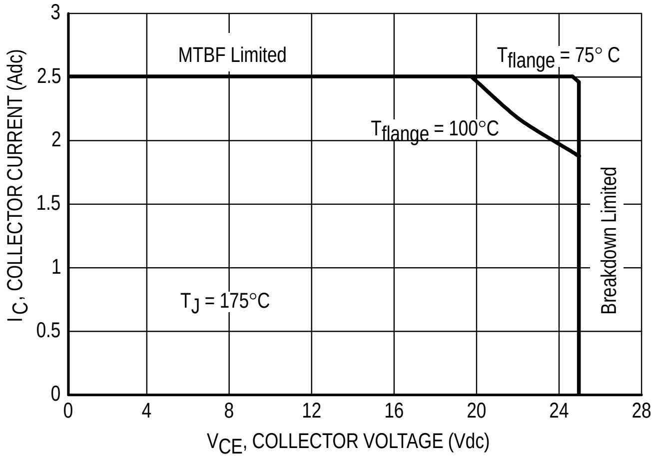


Figure 9. DC Safe Operating Area

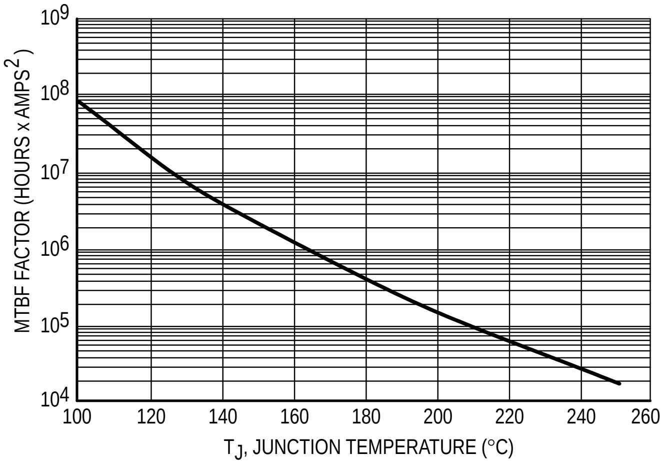
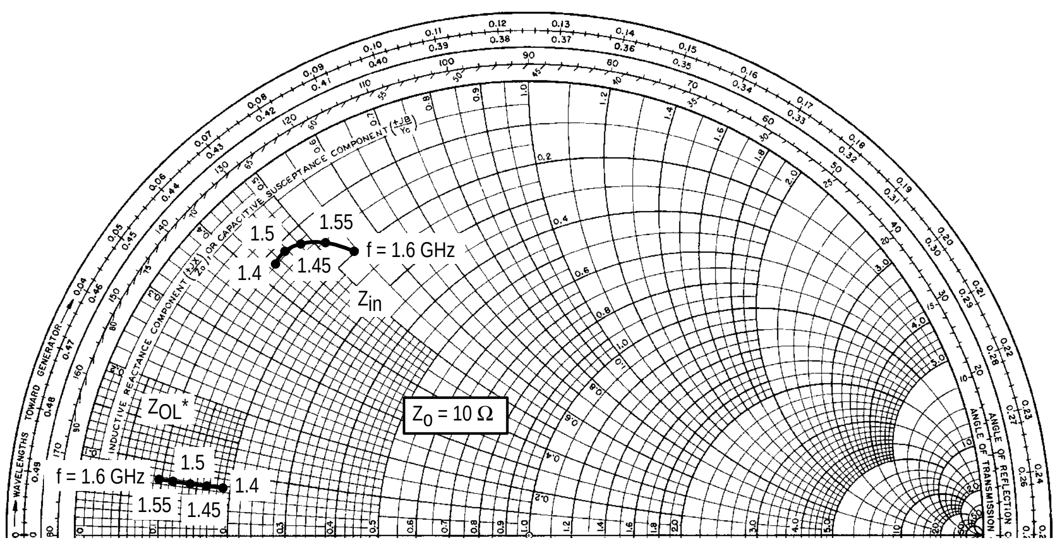


Figure 10. MTBF Factor versus Junction Temperature

The above graph displays calculated MTBF in hours x ampere^2 emitter current. Life tests at elevated temperatures have correlated to better than ±10% of the theoretical prediction for metal failure. Divide MTBF Factor by I_C^2 for MTBF in a particular application.



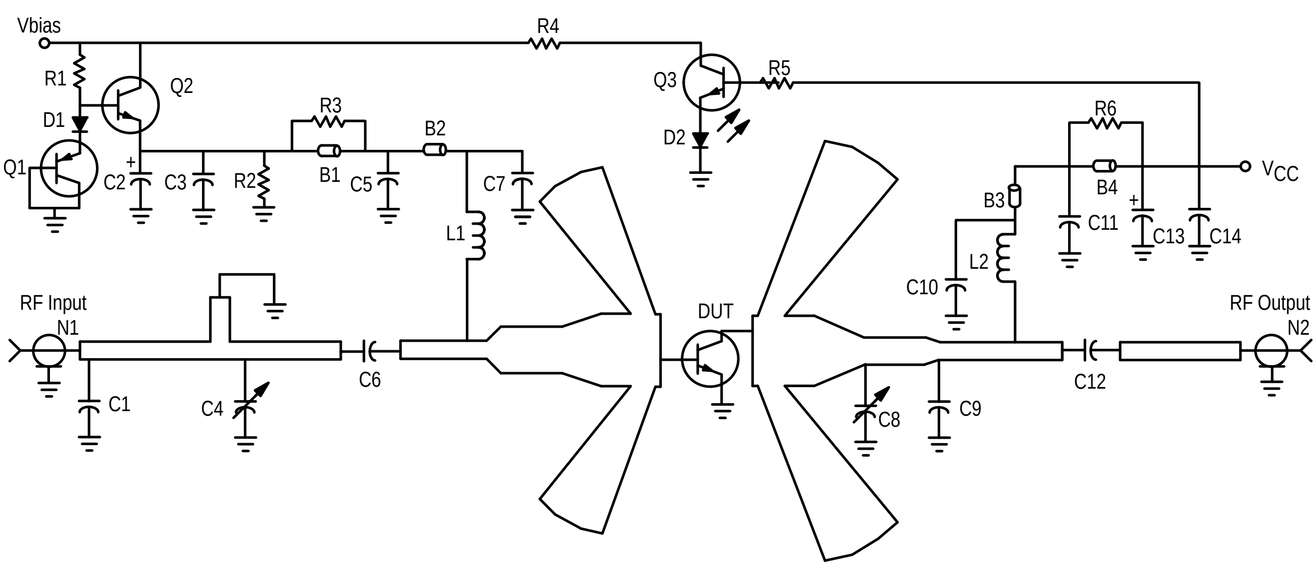
f (GHz)	Z_{in} (Ω)	Z^*_{OL} (Ω)
1.40	1.15 + j4.25	1.87 + j0.78
1.45	1.15 + j4.55	1.67 + j0.78
1.50	1.20 + j4.80	1.47 + j0.78
1.55	1.45 + j5.15	1.27 + j0.78
1.60	1.89 + j5.25	1.00 + j0.78

Z^*_{OL} = Conjugate of optimum load impedance into which the device operates at a given output power, voltage and frequency.

Figure 11. Input and Output Impedances with Circuit Tuned for Maximum Gain @ P_{out} = 30 Watts (PEP), V_{CC} = 26 Volts, I_{CQ} = 125 mA, and Driven by Two Equal Amplitude Tones with Separation of 100 KHz

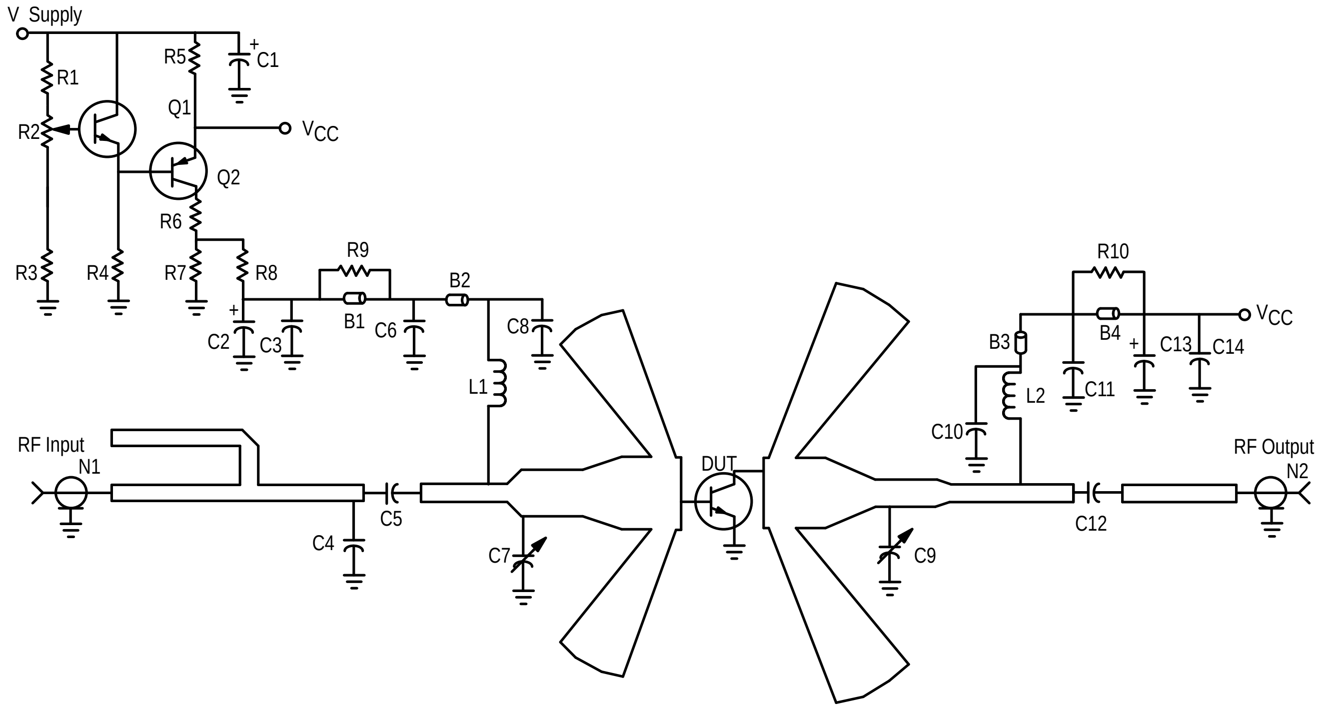
Table 1. Small Signal S Parameters at V_{CE} = 24 Vdc, I_C = 2.5 Adc

f	S_{11}		S_{21}		S_{12}		S_{22}	
MHz	$\|S_{11}\|$	∠ φ	$\|S_{21}\|$	∠ φ	$\|S_{12}\|$	∠ φ	$\|S_{22}\|$	∠ φ
1000	0.983	173	0.366	49	0.006	36	0.890	178
1050	0.984	172	0.367	46	0.007	33	0.893	178
1100	0.978	172	0.367	43	0.007	33	0.888	178
1150	0.975	171	0.373	40	0.007	30	0.885	178
1200	0.975	171	0.382	36	0.008	31	0.886	177
1250	0.969	170	0.391	33	0.007	27	0.881	177
1300	0.963	169	0.408	29	0.008	21	0.879	177
1350	0.955	169	0.428	25	0.009	20	0.879	177
1400	0.945	168	0.452	20	0.008	7	0.873	177
1450	0.933	167	0.487	13	0.009	1	0.875	178
1500	0.915	166	0.525	6	0.009	– 8	0.875	178
1550	0.889	166	0.572	– 3	0.009	–18	0.877	178
1600	0.856	166	0.618	–16	0.009	– 35	0.887	178
1650	0.833	168	0.654	– 30	0.010	– 54	0.901	178
1700	0.820	171	0.654	– 48	0.010	– 86	0.918	178
1750	0.839	174	0.600	– 66	0.010	–120	0.930	177
1800	0.872	175	0.517	– 81	0.010	–152	0.932	176
1850	0.909	176	0.435	– 94	0.010	–176	0.925	174
1900	0.937	175	0.357	–104	0.011	159	0.924	173
1950	0.957	174	0.296	–112	0.012	148	0.917	173
2000	0.970	173	0.247	–119	0.012	136	0.915	173



B1, B4	Long Bead, Fair Rite
B2, B3	Short Bead, Fair Rite
C1	0.3 pF, B Case Chip Capacitor, ATC
C2	220 µF, Electrolytic Capacitor, Mallory
C3, C14	0.1 µF, Chip Capacitor, Kemit
C4, C8	0.8 to 8 pF, Variable Capacitor, Johanson
C5, C11	1800 pF, Chip Capacitor, Kemit
C6, C12	18 pF, B Case Chip Capacitor, ATC
C7, C10	51 pF, Chip Capacitor, Murata Erie
C9	1.7 pF, B Case Chip Capacitor, ATC
C13	470 µF, Electrolytic Capacitor, Mallory
D1	Surface Mount Diode, Motorola
D2	Light Emitting Diode, Industrial Devices
L1, L2	3 Turn, 20 AWG, 0.126″ ID Choke
N1, N2	Type N Flange Mount RF Connector, Omni Spectra
Q1	Transistor PNP Motorola (BD136)
Q2, Q3	Surface Mount Transistor, NPN, Motorola (MJD47)
R1	2 x 330 Ω, 1/8 Watt Chip Resistors in Parallel, Rohm
R2	100 Ω, 1/8 Watt, Chip Resistor, Rohm
R3, R6	4 x 38 Ω, 1/8 Watt, Chip Resistors in Parallel, Rohm
R4	39 Ω, 1/8 Watt, Chip Resistor, Rohm
R5	22 KΩ, 1/8 Watt, Chip Resistor, Rohm
Board	Glass Teflon®, Arlon GX–0300–55–22, ε_r = 2.55

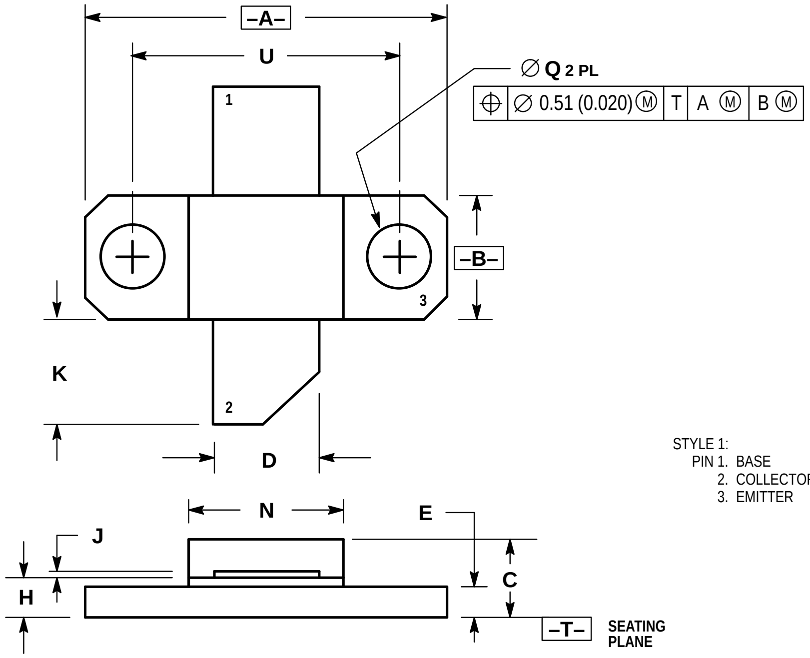
Figure 12. Class AB Broadband Test Fixture Electrical Schematic



B1, B4	Long Bead, Fair Rite	Q1	Transistor NPN Motorola (BD135)
B2, B3	Short Bead, Fair Rite	Q2	Transistor PNP Motorola (BD136)
C1, C2	100 µF, Electrolytic Capacitor, Mallory	R1	250 Ω, 1/8 Watt, Chip Resistor Rohm
C3, C14	0.1 µF, Chip Capacitor, Kemit	R2	500 Ω, 1/4 Watt Potentiometer, State of the Art
C4	1.3 pF, B Case Chip Capacitor, ATC	R3	4.7 KΩ, 1/8 Watt, Chip Resistor, Rohm
C5, C12	18 pF, B Case Chip Capacitor, ATC	R4	2 x 4.7 KΩ, 1/8 Watt, Chip Resistors in Parallel, Rohm
C6, C11	1800 pF, Chip Capacitor, Kemit	R5	1.0 Ω, 10 Watt, Resistor, Dale
C7, C9	0.8 to 8 pF, Variable Capacitor, Johanson	R6	38 Ω, 1.0 Watt, Resistor
C8, C10	51 pF, Chip Capacitor, Murata Erie	R7	75 Ω, 1/8 Watt, Chip Resistor, Rohm
C13	470 µF, Electrolytic Capacitor, Mallory	R8	2 x 10 Ω, 1/8 Watt, Chip Resistors in Parallel, Rohm
L1, L2	3 Turn, 20 AWG, 0.126″ ID Choke	R9, R10	4 x 38 Ω, 1/8 Watt, Chip Resistors in Parallel, Rohm
N1, N2	Type N Flange Mount RF Connector, Omni Spectra	Board	Glass Teflon®, Arlon GX–0300–55–22, ε_r = 2.55

Figure 13. Class A Test Fixture Electrical Schematic

PACKAGE DIMENSIONS



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.739	0.750	18.77	19.05
B	0.240	0.260	6.10	6.60
C	0.165	0.198	4.19	5.03
D	0.215	0.225	5.46	5.72
E	0.055	0.070	1.40	1.78
H	0.079	0.091	2.01	2.31
J	0.004	0.006	0.10	0.15
K	0.210	0.240	5.33	6.10
N	0.315	0.330	8.00	8.38
Q	0.125	0.135	3.18	3.42
U	0.560 BSC		14.23 BSC	

STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER

CASE 395C–01
ISSUE A

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